

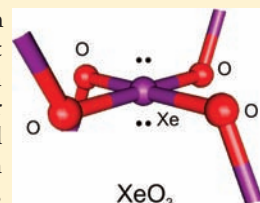
Synthesis of the Missing Oxide of Xenon, XeO₂, and Its Implications for Earth's Missing Xenon

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Supporting Information

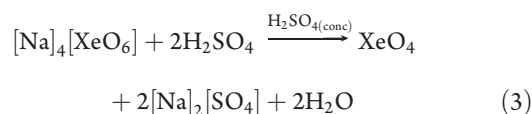
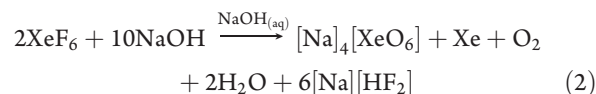
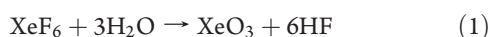
ABSTRACT: The missing Xe(IV) oxide, XeO₂, has been synthesized at 0 °C by hydrolysis of XeF₄ in water and 2.00 M H₂SO_{4(aq)}. Raman spectroscopy and ^{16/18}O isotopic enrichment studies indicate that XeO₂ possesses an extended structure in which Xe(IV) is oxygen bridged to four neighboring oxygen atoms to give a local square-planar XeO₄ geometry based on an AX₄E₂ valence shell electron pair repulsion (VSEPR) arrangement. The vibrational spectra of Xe¹⁶O₂ and Xe¹⁸O₂ amend prior vibrational assignments of xenon doped SiO₂ and are in accordance with prior speculation that xenon depletion from the Earth's atmosphere may occur by xenon insertion at high temperatures and high pressures into SiO₂ in the Earth's crust.



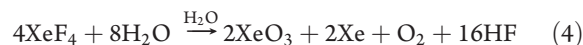
INTRODUCTION

Atmospheric studies of Earth and Mars have shown that xenon is depleted by a factor of approximately 20 relative to the lighter noble gases (Ne, Ar, Kr).¹ More recent studies have found that as much as 90% of the Earth's primordial xenon is absent from its atmosphere,² and that more than 99% of xenon has been degassed from the Earth's mantle.³ It has also been shown that the Earth's core is unlikely to function as a xenon reservoir.^{4,5} These findings have aroused the curiosity of researchers from across a broad range of disciplines spanning planetary, mineralogical, geological, nuclear, and other physical sciences as well as theoretical and computational sciences who have attempted to account for atmospheric xenon depletion. Among the explanations that have been advanced to account for xenon depletion are entrapment in ices,⁶ water clathrates,⁷ sediments,⁸ and early escape from the atmosphere;⁹ however, all four hypotheses have been shown to be untenable.^{6–9} It has also been proposed that xenon displaces silicon from quartz (SiO₂) at the high pressures (0.7–5 GPa) and temperatures (500–1500 K) that are encountered in the continental crust, with the implication that xenon may be retained within silicate minerals and SiO₂ as XeO₂.¹⁰ The high abundance of SiO₂ would make it a significant and readily available reservoir for xenon.

In addition to offering a potential explanation for the Earth's missing xenon, the possible formation of XeO₂ in the Earth's crust is of fundamental chemical interest because XeO₂ represents the missing oxide of xenon. Shortly after the discovery of noble-gas reactivity,¹¹ solid, colorless XeO₃ was synthesized by hydrolysis of XeF₆ (eq 1)^{12,13} and was followed shortly thereafter by the discovery of XeO₄, a pale yellow, volatile solid (eq 2 and 3).^{14,15} Both oxides are highly endothermic and shock sensitive (ΔH_f XeO₃, 402 kJ mol⁻¹; ΔH_f XeO₄, 643 kJ mol⁻¹).¹⁶



In contrast, xenon monoxide, XeO, has not been synthesized and has been shown³ by gas-phase quantum-chemical calculations to have an unstable Π ground state and, therefore, is unlikely to exist as a monomer.¹⁷ It was initially postulated that the hydrolysis product of XeF₄ was either Xe(OH)₄ or XeO₂ · 2H₂O,¹⁸ but subsequent studies showed the final product to be XeO₃, which arose from the redox disproportionation given in eq 4.^{19,20}



Another early study reported the hydrolysis of XeF₄ and the formation of a transient yellow solid at 0 °C. The reaction conditions, which influenced the stability of this species, were optimized by adjusting the acidity of the aqueous medium, but the yellow product was never isolated or characterized.²¹ A subsequent study in which XeF₄ and H₂O were co-condensed at –80 °C yielded a pale-yellow product that was incorrectly equated with the aforementioned transient yellow species, and purported to be XeOF₂.²² This proposal was subsequently refuted when XeOF₂ was synthesized and definitively characterized, showing the pale-yellow co-condensed product to be a mixture of XeOF₂ and XeOF₂ · nHF,²³ and by the current study

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which shows the transient yellow species possesses a Raman spectrum that does not correspond to that of either XeOF_2 or $\text{XeOF}_2 \cdot n\text{HF}$.

RESULTS AND DISCUSSION

In the present study, the aforementioned transient yellow solid was synthesized at 0 °C by the addition of crystalline XeF_4 to either water or 2.00 M $\text{H}_2\text{SO}_4(\text{aq})$. In both cases, intense, yellow-orange suspensions initially formed which, upon mixing for ca. 20 s at 0 °C, produced bright yellow suspensions. The “aged” bright yellow solids are consistent with macromolecular XeO_2 (vide infra) while the initial yellow-orange products are possibly a mixture of molecular XeO_2 and/or lower molecular

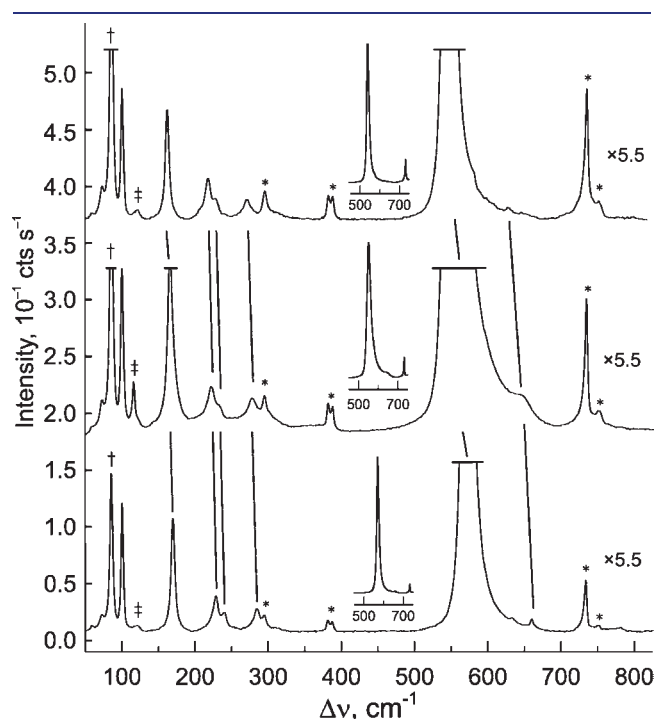
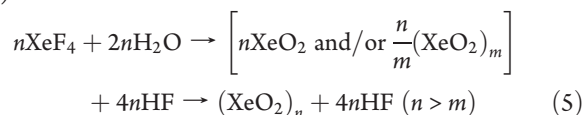


Figure 1. Raman spectra of natural abundance (lower trace), 50% (middle trace), and 97.8% ^{18}O -enriched (upper trace) XeO_2 recorded under frozen water at -150 °C using 1064 nm excitation. Symbols denote FEP sample tube lines (*), instrumental artifact (+), and minor, incompletely polymerized (yellow-orange) product(s) (‡).

weight polymorphs resulting from incomplete polymerization (eq 5).



The products were precipitated by briefly centrifuging the reaction mixture at 0 °C followed by immediate quenching at -78 °C and recording the Raman spectrum in situ at -150 °C. At no time were the supernatants discolored, indicating that the yellow products are insoluble in acidified aqueous media. The Raman spectra of the products formed in water and 2.00 M $\text{H}_2\text{SO}_4(\text{aq})$ were identical, indicating that HSO_4^- is not involved in the product.

The yellow product is kinetically stabilized at low temperatures but decomposes rapidly near ambient temperature. At the reaction temperature, 0 °C, the yellow color persisted for ca. 2 min, whereas samples that had been quenched and stored at -78 °C were stable for considerably longer periods with most decomposition occurring over the first 72 h as evidenced by fading of the original color to pale yellow, with a very faint yellow color persisting after 1 week. In each case, Raman spectra of partially decomposed samples revealed only mixtures of the yellow product and small amounts of XeO_3 ²⁴ (i.e., the totally symmetric XeO_3 stretch, A_1 , was observed as a weak, broad band at 780 cm^{-1}).

Hydrolysis of either $[\text{Cs}][\text{XeOF}_3]$ or XeOF_2 in CH_3CN solvent led to mixtures that also contained the aforementioned yellow product, albeit in smaller amounts (see Hydrolyses of $[\text{Cs}][\text{XeOF}_3]$ and XeOF_2 in the Supporting Information), as evidenced by its characteristic Raman band at 570 cm^{-1} (vide infra).

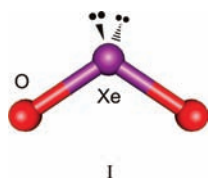
The yellow species was identified and structurally characterized by Raman spectroscopy using ^{18}O and D isotopic enrichment. Reaction of XeF_4 with H_2 ^{18}O resulted in a Raman spectrum that was similar to that obtained from the reaction of XeF_4 with H_2 ^{16}O (Figure 1); however, all vibrational bands were shifted to lower frequencies (Table 1). The presence of a single, intense band in the Xe–O/Xe–F stretching region and the absence of unshifted modes indicate there are no Xe–F bonds in the compound and that the compound is an oxide and/or hydroxy derivative of Xe(IV).²⁶ When XeF_4 was allowed to react with D_2 ^{16}O , the Raman spectrum of the product was identical to that of H_2 ^{16}O reaction product and devoid of any bands that displayed H/D isotopic dependencies, ruling out a hydroxy compound. The most intense band in the spectrum (570.3 cm^{-1}) is assigned to a symmetric stretching mode that is too low to be associated with the symmetric stretch of XeO_3 (780 cm^{-1})²⁴ but too high for a Xe(II) oxide fluoride or oxide.²⁷ The spectrum is therefore

Table 1. Vibrational Frequencies for XeF_4 , Xe^{16}O_2 , $\text{Xe}^{16/18}\text{O}_2$, and Xe^{18}O_2 ^a

XeF_4 ^b	Xe^{16}O_2 ^c	$\text{Xe}^{16/18}\text{O}_2$ ^{c,d}	Xe^{18}O_2 ^c	D_{2d} ^e	assgnts (L = F, O) ^f
586 ν_6 , $\nu(\text{E}_u)$	632.3(1)	626.5sh	625.8(1)	$\nu(\text{E})$	$\nu_{\text{as}}(\text{XeL}_t - \text{XeL}_t)$
554 ν_1 , $\nu(\text{A}_{1g})$	570.3(100)	550.9(100)	542.6(100)	$\nu(\text{A}_1)$	$\nu_s(\text{XeL}_4)$
524 ν_4 , $\nu(\text{B}_{2g})$					$\nu_{\text{as}}(\text{XeL}_{2t} - \text{XeL}_{2t})$
291 ν_3 , $\nu(\text{A}_{2u})$	283.9(3)	276.9(2)	270.0(3)	$\nu(\text{B}_2)$	$\delta(\text{XeL}_4)$ o.o.p., umbrella mode
218 ν_2 , $\nu(\text{B}_{1g})$	239.1(2)	231sh	226.6(2)	$\nu(\text{B}_1)$	$\delta(\text{XeL}_{2c} + \text{XeL}_{2c})$
	227.9(4)	221.3(4)	216.9(6)		
n.o. ν_5 , $\nu(\text{B}_{2u})$	n.o.	n.o.	n.o.	$\nu(\text{A}_2)$	$\delta(\text{XeL}_{2t})$ o.o.p. – $\delta(\text{XeL}_{2t})$ o.o.p.
161 ν_7 , $\nu(\text{E}_u)$ ^g	168.9(13)	165.0(19)	161.1(13)	$\nu(\text{E})$	$\delta(\text{XeL}_{2t})$ i.p.
	99.5(14)	99.3(17)	99.5(15)		lattice mode

^aFrequencies are given in cm^{-1} . ^bFrom ref 25. The symmetries refer to the D_{4h} point symmetry of XeF_4 . ^cValues in parentheses denote Raman intensities. ^dThe sample was prepared by hydrolysis of XeF_4 in an equimolar mixture of H_2 ^{16}O and H_2 ^{18}O . ^eThe symmetries refer to the local D_{2d} point symmetry of the XeO_4 units in the extended structure of XeO_2 . ^fThe abbreviations denote trans (t), cis (c), symmetric (s), asymmetric (as), stretch (ν), bend (δ), in-plane bend (i.p.), and out-of-plane bend (o.o.p.). The in-plane and out-of-plane mode descriptions are relative to the molecular planes of XeF_4 and the XeO_4 -unit. ^gThis mode was not directly observed. The frequency was obtained from the $2\nu_7$ overtone at 322 cm^{-1} .

most consistent with the formation of the Xe(IV) oxide, XeO₂. Moreover, monomeric XeO₂ is predicted to have a bent geometry based on an AX₂E₂ (X = bond pair, E = valence electron lone pair) VSEPR²⁸ arrangement of bond pairs and lone pairs (structure I) and would consequently be a polar molecule. This expectation contrasts with the insolubility of this material in aqueous media, suggesting that XeO₂ likely has an extended (chain or network) structure.

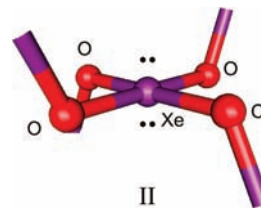


I

The Raman spectra of Xe¹⁶O₂ and Xe¹⁸O₂ (Figure 1) also support extended structures. The vibrational frequencies of gas-phase monomeric XeO₂ have been calculated at the CCSD(T) level of theory using the 6-311 g* and aug-cc-PVTZ basis set for oxygen, giving three Raman-active modes at 647 (668), 205 (206), and 703 (716) cm⁻¹, where the aug-cc-PVTZ values are given in parentheses.²⁹ The bands in the experimental Raman spectra of XeO₂ number six and are broad ($\Delta\nu_{1/2} \approx 20$ cm⁻¹), which is consistent with vibrational coupling and bridge-bonding in an extended structure. A 1:1 molar mixture of H₂¹⁶O and H₂¹⁸O was also used to synthesize XeO₂, as described above, in an attempt to resolve the independent spectra corresponding to the ^{16/18}O isotopomers of monomeric XeO₂, namely, Xe¹⁶O₂, Xe^{16/18}O₂, and Xe¹⁸O₂. Instead of three discrete overlapping isotopomeric spectra, the Raman spectrum was comprised of broadened bands that occurred at frequencies that were intermediate with respect to the spectra of Xe¹⁶O₂ and Xe¹⁸O₂ (Figure 1 and Table 1). This result is also in accordance with an extended XeO₂ structure in which vibrational coupling extends beyond the primary coordination sphere of xenon. The aforementioned behavior of XeO₂ is not unlike that of SiO₂, which forms discrete monomeric units with double bonds to oxygen in the gas phase, and extended networks in the solid state which display extensive vibrational coupling.³⁰

There is a notable similarity between the Raman frequencies of XeO₂ and those of XeF₄ (Table 1), which are in closest agreement for Xe¹⁸O₂, where the atomic mass of ¹⁸O is closest to that of ¹⁹F. This leads to the conclusion that the extended XeO₂ structure has a local square-planar geometry for the XeO₄ unit (structure II). The square-planar structural unit is consistent with the VSEPR model of molecular geometry,²⁸ which is an AX₄E₂ arrangement of four bond pairs and two valence electron lone pairs. This is in accordance with other Xe(IV) compounds which have square-planar (XeF₄,³¹ F₂OXeNCCH₃,²³ XeOF₂,²³ XeOF₃,³² Xe(OTeF₅)₄,³³) or pentagonal-planar (XeF₅,³⁴ [XeF₃][SbF₆],³⁵ [XeF₃][Sb₂F₁₁])³⁶ xenon coordination spheres in the solid state when short secondary contacts are taken into account. However, the bent angles at the oxygen atoms in the extended structure of XeO₂ result in reduction of the local D_{4h} symmetry at xenon and three additional vibrations that are otherwise associated with rotation of the free molecule³⁷ (see Table S1 in the Supporting Information). The observed bands in the Raman spectrum are most consistent with symmetry lowering to D_{2d} symmetry where the planar XeO₄ moiety is predicted to give rise to nine vibrational bands belonging to the irreducible representations A₁ + 2A₂ + B₁ + 2B₂ + 3E, where modes of A₁, B₁, B₂, and E symmetry are Raman active

(seven bands); those of B₁, B₂, and E symmetry are infrared active (six bands); and those of A₂ symmetry are Raman and infrared inactive. The vibrational assignments for XeO₂ are therefore made by analogy with the square-planar D_{4h} symmetry of XeF₄ with the understanding that the vibrational mode descriptions under local D_{2d} symmetry will be very similar.



II

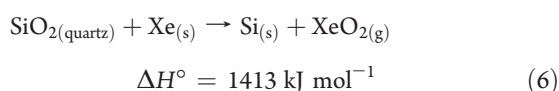
The most intense Raman band of XeO₂ occurs at 570.3 cm⁻¹ and displays an ¹⁸O-isotopic shift of -27.7 cm⁻¹. The band occurs at a frequency that is much lower than the symmetric and asymmetric Xe-O stretches predicted for the gas-phase molecule.²⁹ This is consistent with coordination of the oxygen atoms to neighboring xenon atoms, which imparts single bond character to the Xe-O bonds and lowers the frequencies of the Xe-O stretching modes. A similar trend has been observed for XeOF₂.²³ The 570.3 cm⁻¹ band is assigned to the combined $\nu_s(\text{XeO}_4)$ and $\nu_{as}(\text{XeO}_{2t}-\text{XeO}_{2t})$ modes, where t denotes oxygen atoms trans to one another. These modes are normally associated with $\nu_1(A_{1g})$ and $\nu_4(B_{2g})$ in an isolated square-planar molecule but are rendered degenerate in an extended lattice (structure II) because the elongation of four Xe-O bonds results in the compression of four Xe-O bonds of the four next nearest neighbor XeO₄ groups. The $\nu_2(B_{1g})$ mode of a square-planar molecule appears as two bands at 227.9 and 239.1 cm⁻¹. These bands exhibit ¹⁸O isotopic shifts of -11.0 and -12.5 cm⁻¹, respectively, which are assigned to $\delta(\text{XeO}_{2c} + \text{XeO}_{2c})$.³⁸ The extended lattice of XeO₂ also renders modes Raman-active that would otherwise be exclusively infrared active in an isolated centrosymmetric square-planar molecule. A case in point is the weak band at 283.9 cm⁻¹, which is assigned to the out-of-plane XeO₄ bend, $\nu_3(A_{2u})$, and displays a low-frequency shift (-13.9 cm⁻¹) upon ¹⁸O-enrichment. Similarly, the otherwise Raman-inactive modes, XeO_t-XeO_v, and the in-plane bend, XeO_{2v}, corresponding to $\nu_6(E_u)$ and $\nu_7(E_u)$, respectively, are observed at 632.3 and 168.9 cm⁻¹ with ¹⁸O isotopic shifts of -6.5 and -7.8 cm⁻¹, respectively. The out-of-plane coupled bending mode, $\delta(\text{XeO}_{2t})_{\text{o.o.p.}} - \delta(\text{XeO}_{2t})$, corresponding to $\nu_5(B_{2u})$, which is formally both Raman and infrared inactive in isolated square-planar centrosymmetric molecules, is also not observed for XeO₂.

The Raman spectrum of the yellow-orange, incompletely polymerized product (Figure S1 in the Supporting Information) is very similar to that of the fully polymerized yellow solid with the exception of a broadened 570 cm⁻¹ band, which tails off to higher frequency (~680 cm⁻¹), and a weak band at 310 cm⁻¹. These features may be attributed to shorter oligomers or smaller network structures that have not fully condensed.

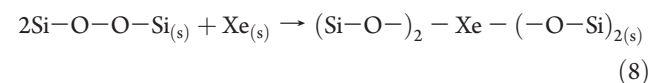
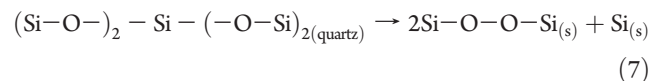
Prior work¹⁰ reporting xenon doped SiO₂ has been re-examined in light of the present findings. The study assumed that xenon substitution for silicon in a SiO₂ lattice resulted in xenon occupancy at a tetrahedral site. For this reason, the local xenon geometry was compared with that of XeO₄,³⁹ assuming that the Xe-O bond lengths and vibrational frequencies of the gas-phase XeO₄ molecule are transferable.¹⁰

Consequently, the latter assumption and ensuing comparisons are flawed. The valence shell of Xe(IV) in XeO₂ possesses two valence electron lone pairs. If Xe(IV) were to form bonds to four oxygen atoms in a silicate environment, they would be single bond domains and would adopt a local square-planar AX₄E₂ VSEPR²⁸ arrangement around Xe(IV) as in structure II. Xenon in tetrahedral XeO₄ is in the +8 oxidation state, forming four double bonds to the oxygen atoms.³⁹ The prior argument¹⁰ ignores the formal oxidation state of xenon, formal Xe–O single bond orders, and stereochemical activities of the two valence electron lone pairs on Xe(IV). Therefore, the bond lengths and Raman frequencies observed for gas-phase XeO₄ are invalid comparisons. The present arguments are supported by a recent report that provides several calculated models for xenon insertion into SiO₂ networks.⁴⁰ One such model positioned xenon at a tetrahedral site which, when energy optimized, gave a local square-planar geometry at xenon. Unfortunately, the steric effects of the free valence electron lone pairs on Xe(IV) and relevant VSEPR arguments were not considered and the optimized square-planar geometry was attributed to packing constraints and stabilization by the surrounding environment.⁴⁰

Thermodynamic considerations in the prior reports of xenon-doped SiO₂¹⁰ attribute the formation of XeO₂ to PV work that resulted from an increase in unit cell size and to the high pressures attained in the experiment.¹⁰ The PV work was estimated to be -700 kJ mol^{-1} , noting that it “favors the reaction that is otherwise inhibited at ambient conditions because of the high formation enthalpy predicted for XeO₂²⁹ compared with that of SiO₂.” Although -700 kJ mol^{-1} is sufficient to overcome $\Delta H_f^\circ \text{ XeO}_{2(g)}$ (487 kJ mol^{-1}),²⁹ an ambiguity arises when $\Delta H_f^\circ \text{ SiO}_{2(\text{quartz})}$ ($-910.94 \text{ kJ mol}^{-1}$)⁴¹ and $\Delta H_{\text{sub}}^\circ \text{ Xe}_{(s)}$ ($-15.0(2) \text{ kJ mol}^{-1}$)⁴² are also considered in eq 6, resulting in a highly endothermic (713 kJ mol^{-1}) process when the volume reduction work is included. Equation 6 neglects the lattice enthalpy of XeO₂, which is unknown, but were it to exceed 713 kJ mol^{-1} , when coupled with the error in the estimated PV work, the process could be rendered spontaneous.



The plausibility of reaction (6) is supported by a recent computational study relating to xenon insertion into SiO₂ networks.⁴⁰ This study concluded that xenon could be incorporated into the interstitial spaces of SiO₂ lattices under ambient conditions and that xenon could replace silicon at higher pressures in a two-step process. The initial step requires a substantial amount of energy and involves a redox process in which Si atoms are removed from the lattice and Si–O–O–Si peroxi-linkages are formed (eq 7). The xenon incorporation step (eq 8) has an energy barrier of 177 kJ mol^{-1} .⁴⁰



In view of the aforementioned computational results, which support xenon substitution into SiO₂ networks, the previous

Raman spectrum of xenon doped SiO₂ obtained from a high-pressure and high-temperature study¹⁰ was re-examined in light of the present findings. The spectrum is consistent with the presence of covalently bound xenon, but the vibrational bands were incorrectly assigned. A band at 588 cm^{-1} was assigned “to the main Raman band of SiO units, located at 596.4 cm^{-1} at room temperature in the gas phase.”¹⁰ The reference alluded to by the authors actually quotes SiO stretches ranging from 460.2 to 627.9 cm^{-1} for $(\text{SiO})_n$ ($n = 2-4$) in a solid methane matrix at 25 K .⁴³ The 588 cm^{-1} band is in good agreement with the experimental frequency for bulk XeO₂ (570.3 cm^{-1}) obtained in the present study and more likely arises from modes whose descriptions approximate $\nu_s(\text{XeO}_4)$ and $\nu_{\text{as}}(\text{XeO}_{2t}-\text{XeO}_{2t})$. Bands at 814 and 356 cm^{-1} were also previously assigned to XeO₂,¹⁰ but more likely arise from Si–O_{Xe} stretching and O–Si–O_{Xe} bending modes, respectively, where O_{Xe} denotes oxygen bound to xenon. These bands are in good agreement with the E and A₁ modes observed for solid SiO₂ at 795 and 356 cm^{-1} , respectively,⁴⁴ and are reassigned accordingly.

CONCLUSION

The present study has provided the synthesis and Raman spectroscopic characterization of macroscopic amounts of XeO₂. Raman spectroscopic studies employing ¹⁶O/¹⁸O isotopic enrichment indicate that XeO₂ possesses an extended structure having a local square-planar XeO₄ geometry around Xe(IV). Xenon dioxide presently represents the only known covalent network structure for a noble-gas compound that exists under near-ambient conditions. The present Raman spectroscopic studies of XeO₂ also correct prior vibrational assignments of xenon-doped SiO₂ containing covalently bound xenon (2.2%) that had been substituted for silicon in a quartz matrix under high-temperature and high-pressure conditions.¹⁰ Such xenon-doped SiO₂ lattices offer the possibility that covalently bound xenon occurs in natural silicates that have been cycled deep into Earth’s crust. This could serve to deplete the amount of xenon relative to the lighter noble gases in the atmosphere, providing a plausible explanation for the Earth’s missing xenon.

EXPERIMENTAL SECTION

Low-temperature ($-150 \text{ }^\circ\text{C}$) Raman spectra were recorded in situ in $\frac{1}{4}$ -in. o.d. FEP (perfluoro-ethylene/propylene copolymer) reactors as previously described.⁴⁵ Prior to reaction, the reactors were rigorously dried under dynamic vacuum for 24 h and subsequently passivated with F₂ gas for a further 24 h. Under a head of high-purity Ar, 0.400 mL of H₂¹⁶O (Caledon, HPLC grade) [H₂¹⁸O (MSD Isotopes, 97.8 atom % ¹⁸O); H₂¹⁶O/H₂¹⁸O; D₂O (MSD Isotopes, 99.8 atom % D)] was syringed into a $\frac{1}{4}$ -in. FEP reactor, which was plugged with a Teflon cap, and cooled to $0 \text{ }^\circ\text{C}$ in an ice/water bath. Once cooled, the cap was briefly removed and $40-50 \text{ mg}$ of crystalline XeF₄⁴⁶ was added to the reactor, a few crystals at a time. **NOTE:** When water was added directly to solid XeF₄, or XeF₄ crystals were added too rapidly, heat generated by the reaction could not be adequately dissipated, resulting in extensive decomposition of XeO₂ to Xe and O₂ which ejected the remaining water and product from the reactor. A bright, yellow-orange suspension immediately formed upon contact, but upon mixing for ca. 20 s at $0 \text{ }^\circ\text{C}$ the color of the suspension changed to yellow. The yellow solid was found to be XeO₂ (vide supra), whereas the yellow-orange product was possibly a mixture of molecular XeO₂ and/or lower molecular weight polymorphs resulting from incomplete polymerization. The reactor containing the yellow solid was then placed in an ice/water bath in a centrifuge and centrifuged for 10 s at 7000 rpm at a radial distance of 13 cm . The

sample was removed and immediately quenched at $-78\text{ }^{\circ}\text{C}$ and the Raman spectrum was recorded at $-150\text{ }^{\circ}\text{C}$.

ASSOCIATED CONTENT

Supporting Information. Hydrolyses of $[\text{Cs}][\text{XeOF}_3]$ and XeOF_2 ; synthesis of XeO_2 in nonaqueous media; site symmetry analyses for the XeO_4 moiety in the polymeric structure of XeO_2 (Table S1); Natural abundance Raman spectra of yellow-orange, incompletely polymerized product(s) and yellow, macromolecular XeO_2 (Figure S1). This material is available free of charge via the Internet at <http://pubs.acs.org>.

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- The bands for the symmetric Xe–O–Xe stretch of $[\text{Xe}_3\text{OF}_3]^-$ $[\text{AsF}_6]^-$, which couple with the terminal Xe–F stretching modes, occur at 419, 430, and 480 cm^{-1} . Because they correspond to a Xe(II) cation, they are among the highest single bond Xe–O stretching frequencies expected for a Xe(II)–O bonded species. Gerken, M.; Moran, M. D.; Mercier, H. P. A.; Pointner, B. E.; Schrobilgen, G. J.; Hoge, B.; Christe, K. O.; Boatz, J. A. *J. Am. Chem. Soc.* **2009**, *131*, 13474–13489.
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